

## SINGLE TEST RECORD FORM

<b>Test No:</b> 1&2 (unstructured)	<b>Profile edition No:</b> 1	<b>Tool:</b> EDF Converter <i>2.7</i> <i>Migration Converter</i>	<b>Score:</b> 3
<b>Test files: ENTSO-E Test Files</b>			
<b>Import</b>		<b>Export</b>	
UCTE21U_DEF_r3.uct		UCTE21U_DEF_r3.xml UCTE21U_DEF_r3DE_EQ.xml UCTE21U_DEF_r3DE_TP.xml UCTE21U_DEF_r3DE_SV.xml UCTE21U_DEF_r3NL_EQ.xml UCTE21U_DEF_r3NL_TP.xml UCTE21U_DEF_r3NL_SV.xml	
<b>Comments/Results/Issues:</b>			
<p>Data conversion from uct to ENTSO_E CIM ed.1 has been performed (UC→CIMXML).          The CIM data has been validated by CIMdesk tool.          The problem of duplicateing TopologicalNode and/or ConductingEquipment names within          single GeographicalRegion/VoltageLevel and/or Topological Node respectively has been          discovered.</p>			
<b>Supplementary files:</b>			
Errors_edf CIM converter.doc			
<b>Date</b>	<b>Vendor</b>	<b>Test witness</b>	
15/7/2011	<b>Name</b>	<b>Signature</b>	<b>Name</b>
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